Circuit Quantum Electrodynamics with Electrons on Helium

D. I. Schuster,¹ A. Fragner,¹ M. I. Dykman,² S. A. Lyon,³ and R. J. Schoelkopf¹

¹Department of Applied Physics and Physics, Yale University

²Department of Physics and Astronomy, Michigan State University

³Department of Electrical Engineering, Princeton University

(Dated: December 14, 2009)

We propose to couple an on-chip high finesse superconducting cavity to the lateral-motion and spin state of a single electron trapped on the surface of superfluid helium. We estimate the motional coherence times to exceed 15 μ s, while energy will be coherently exchanged with the cavity photons in less than 10 ns for charge states and faster than 1 μ s for spin states, making the system attractive for quantum information processing and cavity quantum electrodynamics experiments. Strong interaction with cavity photons will provide the means for both nondestructive readout and coupling of distant electrons.

PACS numbers:

Electrons on helium form a unique two dimensional electron gas (2DEG) at the interface between a quantum fluid (superfluid helium) and vacuum. The system has exceptional bulk properties, with the highest measured electron mobility $> 10^8 \,\mathrm{cm}^2/\mathrm{Vs}[1]$ and spin coherence times predicted to exceed 100 s[2]. For these reasons electrons on helium were among the first systems proposed for quantum information processing[3]. The initial proposals focused on the motional states of a single trapped electron normal to the helium surface[4], which promise long coherence times but have transition frequencies exceeding 100 GHz. Further, they were to be detected (destructively) using state-selective ionization and electron multiplying multichannel plate detectors, a significant technical challenge. More recently a promising proposal has suggested the electron spin as the quantum state of interest[2], but it has not been clear how to best read-out or couple these spins.

Here, we address these challenges using the recently developed circuit QED architecture[5] to detect the quantized *in-plane* motion of a single trapped electron. The in-plane motion can be engineered to have transition frequencies of a few GHz, and could be readily coupled to an on-chip cavity for non-destructive readout analogous to that used for superconducting gubits[5] or electron cyclotron motion in g-2 experiments[6]. In addition, the coupling of the electron spin to single photons and other spins would be significantly enhanced by a controllable spin-orbit coupling, using mechanisms reminiscent of those proposed for semiconductor quantum dots[7]. The trapped electrons can be considered as quantum dots on helium operating in the single electron regime. These dots would be sufficiently small (sub-micron) that the lateral spatial confinement and potential depth will determine the orbital properties. The feasibility of creating such nano-scale traps is buoyed by recent experiments in which few electron charge coupled devices (CCD's) transported electrons around a microchip with high efficiency, indicating the absence of charge traps[8]. There has also been an experiment which has detected single electron tunneling events and counted electrons entering a micron-sized quantum dot[9]. However, so far there have been no observations of either intradot quantization or spin resonance on helium.

It is instructive to compare electrons on helium with traditional semiconductor quantum dots. In most traditional 2DEG's such as GaAs the electrons form a degenerate gas with effective masses $(m_{\rm e,GaAs}^* \approx 0.067 m_{\rm e})$ much smaller than that of a free electron and with renormalized g-factors ($g_{\rm GaAs} \approx -0.44$). The light mass leads to an enhancement of quantum effects, which has aided in the recent success of laterally-defined single electron quantum dot experiments[10, 11]. However, because of the strong piezoelectric coupling to the substrate the motional states have short coherence times ($\sim 100 \text{ ps}$)[12]. For this reason spin is typically used[10, 11, 13], but its coherence time can be strongly affected by nuclear spins[13, 14]. In contrast, electrons on helium retain their undressed mass and g-factor and partially for this reason the study of helium quantum dots is less mature. With the techniques described here, single electron quantum dots on helium promise some advantages over traditional semiconducting dots. We predict the decay of the orbital states to be 10^4 times slower than in GaAs. Further, superfluid ⁴He has no nuclear spins $(10^{-6}$ natural abundance of ³He), leading to long predicted spin coherence times, which are primarily limited by current noise in the trap leads. Perhaps most importantly, electrons on helium is a fascinating system where coherent single particle motion has not been accessible until now.

An electron near the surface of liquid helium will experience a potential due to the induced image charge of the form $V = \Lambda/z$, with $\Lambda = e^2(\epsilon - 1)/4(\epsilon + 1)$ and $\epsilon \approx 1.057$. Together with the 1 eV barrier for penetration into the liquid, the image potential results in a hydrogen-like spectrum $E_{\rm m} = -R/m^2$ of motion normal to the surface, with an effective Rydberg energy $R \sim 8$ K and Bohr radius 8 nm[15]. At the proposed working temperature of 50 mK the electron will be frozen into the ground out-of-plane state, and the helium will be a superfluid with negligible vapor pressure.

With the vertical motion eliminated, the electron's lat-



FIG. 1: Top view of electrostatic electron trap. The ground plane and cavity center pin are shown in blue, while the trap electrode is magenta. The configuration of center pin and ground plane provide two-dimensional confinement. A DC voltage, V_e is provided via a wire insulated from the resonator. Manipulation and readout is performed via an RF voltage applied to the input port of the resonator with the modified signal measured by a cryogenic amplifier at the output port.

eral motion within an electrostatic trap could be coupled to the electric field of a superconducting transmission line cavity. As shown in Figs. 1 & 2, the cavity center-pin and ground plane form a split-guard ring around a positively biased trap electrode. We approximate the trapping potential in each of the lateral dimensions as being nearly harmonic, with level spacing $\approx \hbar \omega_{x,y}$. We assume a high-aspect ratio trap so that the x and y motional frequencies are distinct. It may also be interesting in the future to consider low-aspect ratio traps in which angular momentum could be a useful quantum resource. Because the trap is small and the potential must flatten at the outer electrodes, it has a small quartic perturbation $V_{\alpha} = \hbar \alpha x^4 / 3a_x^4$, where $a_x = (\hbar / m \omega_x)^{1/2}$ is the standard deviation of the motional ground state wavefunction, and α is the anharmonicity of the first few levels. The Hamiltonian can be approximated as

$$H = \frac{\hat{p}_x^2}{2m_e} + \frac{1}{2}m_e\omega_x^2 \hat{x}^2 + \hbar\alpha \frac{\hat{x}^4}{3a_x^4}$$
(1)

with the *n* to *n*+1 transition frequency $\omega_{x,n} \approx \omega_{x,0} + (n+1)\alpha$. The electron motion can be treated as a qubit when α is larger than the decoherence rates[16]. The scaling of the system parameters with geometry (see Fig. 2) can be estimated analytically by approximating the trap potential as $V_t \cos(2\pi x/W)$. In this case $\omega_x = 2\pi (eV_t/meW^2)^{1/2}$, $\alpha = (2\pi/W)^2\hbar/8m_e$, and $V_t \approx V_e e^{-2\pi d/W}$, therefore one can tune the motional frequency by adjusting the bias voltage, determine the anharmonicity by the trap size (confinement effects), and trade-off sensitivity in bias voltage for sensitivity to trap height (generally $d \sim W$ so as to avoid exponential sensitivity to film thickness).

To get more accurate estimates, we simulate the trapping potential and resulting wavefunctions for the specific geometry shown in Figs. 1 & 2 using physically reasonable trapping parameters: helium depth d = 500 nm, trap size W = 500 nm, trapping voltage $V_{\rm e} = 10$ mV. These result in a trap depth $eV_{\rm t}/h \approx 20$ GHz \gg k_BT deep



FIG. 2: Side view of trap electrodes with energy levels and wavefunctions of electron motional state. The electron is confined to the surface of the helium film of thickness, d. The trap electrode (magenta) is biased positive relative to the ground and center pin (blue) of the CPW to laterally confine the electron. These electrodes form a confining potential which is harmonic to first order, but which flattens over the outer electrodes, giving it a small softening anharmonicity. A sample potential and nearly-harmonic wavefunctions are shown. The spatial extent of the electron zeropoint motion a_x is small compared to the characteristic size of the trap w. To define a spin quantization axis a magnetic field in the x-direction is applied. To couple the motional and spin degrees of freedom one can apply a current through the center electrode creating a z-field gradient within the trap.

enough to prevent thermal escape, and a transition frequency $\omega_x/2\pi \approx 5 \text{ GHz}$ convenient to microwave electronics. The electron's motion within the trap is affected by and induces an electric field in the microwave cavity. If the level spacing $\hbar\omega_x$ is in resonance with the energy of a cavity photon, the two systems can exchange energy at the vacuum Rabi frequency, $2g = \sqrt{2}ea_xE_0/\hbar$ where $E_0 \sim 2 \text{ V/m}$ is the zero-point electric field in the cavity. The electron motional states can be manipulated quickly due to the large coupling strength $g/2\pi = 20 \text{ MHz}$, a consequence of the large electron dipole moment $ea_x/\sqrt{2} \sim 2 \times 10^3 \text{ Debye}$, and without exciting transitions to higher lateral states due to the anharmonicity $\alpha/2\pi \approx -100 \text{ MHz}$.

In addition to the motional degree of freedom, the electron carries a spin degree of freedom. The coupling of the cavity photons to the spin is many orders of magnitude weaker than to the charge, but can be enhanced via controlled spin-motion coupling. A spin-quantization axis is established using a magnetic field in the \hat{x} direction (Fig. 2). The Larmor frequency is approximately $\omega_{\rm L} = 2\mu_{\rm B}/h \approx 2.89 \,{\rm MHz/G}$. Niobium CPW cavities have been demonstrated to maintain Q > 20,000 in parallel fields of up to 2 kG, allowing Larmor frequencies of up to $\omega_{\rm L} \sim 6 \,{\rm GHz}$. The cavity and charge degree of freedom have $\hbar\omega \gg k_{\rm B}T$ so that they thermally relax to the ground

state. It is possible to manipulate the spin magnetically but this requires large RF currents and does not provide an easy channel for measurement.

We propose instead to create a non-uniform z-field component with a gradient along the vibrational axis, $\partial_x B_z$, by passing a current through the center electrode (in the ydirection see Fig. 2). This leads to a new term in the Hamiltonian, $H_s = -2\mu_B s_z x \partial B_z / \partial x$. The resulting spin-orbit interaction provides an enhanced cavity coupling mediated through the motional state. This allows manipulation and readout of individual spins, as well as the use of coupling techniques developed for superconducting qubits[17]. Further, the coupling is proportional to the applied current, allowing the spin-cavity to be tuned in-situ on nanosecond timescales. For a 1 mA current 500 nm away from the electron a $\partial B_z / \partial x \sim 8 \text{ mG/nm}$ field gradient can be created producing a spin vacuum Rabi coupling

$$g_s = \mu_{\rm B} a_x \frac{\partial B_z}{\partial x} \frac{g\sqrt{2}}{\hbar\omega_x (1 - \omega_L^2/\omega_x^2)} \tag{2}$$

For $\omega_L \ll \omega_x$ these parameters give $g_s \sim 8$ kHz. If $\omega_x - \omega_L \approx 10$ MHz then the coupling can be made large $g_s \approx 1.5$ MHz. Alternatively, spin interactions could be mediated via exchange coupling between two co-trapped electrons as is done in semiconducting quantum dots[10], but this would require a double-dot structure and might also prove harder on helium than in GaAs due to the electron's larger mass.

The current also creates a second-order variation in the x-component of \vec{B} , leading to a new term in the Hamiltonian, $H_{\rm sb} = -\mu_{\rm B}x^2\partial_x^2B_xs_x$. If the constant magnetic field is applied along the y-direction, this term will lead to sideband transitions simultaneously changing the orbital and spin states by driving at $\omega_{\pm} = \omega_x \pm \omega_{\rm L}$. These transitions can be used to manipulate, cool, and detect the spin using its coupling to the lateral motion. With such cooling it might allow one to use smaller spin frequencies.

Nearly every aspect of the trapped electron system can be controlled by appropriate choice of geometry and applied voltages. This tunability allows one to engineer the properties of this artificial atom and compensate for defects in trap fabrication. However, it also provides channels for noise to couple to the system, causing decoherence of the motional and spin states[18]. There two major sources of decoherence are from the electrical fluctuations in the leads and excitations in the liquid helium. Here we present a short summary of these mechanisms and their contributions to decoherence (also see Fig. 3). A detailed explanation of these mechanisms is presented in the supplementary materials to this work.

A motionally excited electron can relax radiatively via spontaneous emission directly into free space, through the cavity, or the trap bias electrode. The electron radiates very little into free space, both because it is small ($a_x \ll \lambda$), and because the microwave environment it sees is determined mostly by its surrounding electrodes. Emission



FIG. 3: Decoherence rates of motional states as a function of the trap frequency, at T = 50 mk. Rates are computed using parameters specified in the text. Solid lines are decoherence rates due to energy relaxation ($\Gamma_1/2$), while dashed lines are dephasing rates (Γ_{ϕ}). Single ripplon relaxation rate and phonon dephasing rates are smaller than 1 Hz. Spin decoherence rates are discussed in the text.

through the cavity can be enhanced (for fast initialization) or suppressed (for long lifetimes) via the Purcell effect[19]. In a perfectly symmetric trap, radiation through the bias leads would be suppressed by a parity-selection rule. We conservatively assume that the electron is displaced from the trap center by $\sim a_x$, which gives a relaxation rate $\sim 1.6 \times 10^3 \, s^{-1}$. Though this mechanism is not expected to be dominant, it could be easily reduced significantly by engineering the impedance of the trap bias lead. In addition, slow fluctuations in the trap electrode voltage (V_e) can deform the potential, changing the motional frequency and resulting in dephasing. This can occur from drift in the voltage source, thermal Johnson voltage noise, or local "1/f" charge noise. Drift is relatively small and occurs on time scales slow compared with the experiment time, and is easily compensated. The thermal noise at 50 mK is quite small < 100 Hz. Ideally, any charge fluctuations would be well screened by the trap electrodes and their large capacitance to ground. Even in worst case scenario in which the trap electrode acts like a disconnected island (rather than an electrode with a large capacitance to ground), we estimate a dephasing rate 8×10^{-3} , which would not be the dominant decoherence rate. Noise from the cavity and ground plane electrodes should have less effect as the frequency is insensitive to first order to changes in those voltages.

In addition to decoherence through the electrodes, the electron can lose coherence to excitations in the helium. Two major types of excitations are relevant. One is capillary waves on the helium surface, or ripplons. The other mechanism is loss via phonons in the bulk. The electron is levitated above the surface at height $r_{\rm B} \sim 8$ nm, which greatly exceeds the height of the surface fluctuations, and therefore coupling to the ripplons is small. Because the interatomic interaction in helium is comparatively weak, the characteristic electron speed $a_x \omega_x$ significantly exceeds

the speed of sound v_s in He and the characteristic group velocity of ripplons. As a result, the rate of direct decay with excitation of one ripplon is exponentially small. Decay into ripplons is dominated by second order processes in which two ripplons of nearly opposite momentum simultaneously interact with the electron. Because the coupling to ripplons is weak in the first place, this is a second-order process, the phase volume is limited by the condition on the total ripplon momentum, and the corresponding decay rate is small. It is estimated in the supplementary material to be $\leq 10^3 \text{ s}^{-1}$ (see Fig. 3).

The most important mechanism related to helium excitations is decay into phonons. The coupling to phonons is reminiscent of piezoelectric coupling in semiconductors. An electron creates an electric field that causes helium polarization, which in turn affects the electron. Phonons modulate helium density and thus the polarization, which changes the electron energy. However, in contrast to semiconductors, where the typical polarization constant is $e_{\rm pz} \sim 10^{14} \ e/{\rm cm}^2$ [20], the polarization in He is $\sim e(\epsilon-1)/4\pi r_{\rm B}^2 \sim 10^{10} \ e/{\rm cm}^2$. Therefore coupling to phonons is much weaker than in semiconductors. The corresponding decay rate is $\sim 3 \times 10^4 \ {\rm s}^{-1}$ (see Fig. 3).

Besides decay, coupling to helium excitations leads to fluctuations of the electron frequency and ultimately to dephasing. The major contribution here comes from tworipplon processes, since ripplons are very soft excitations with comparatively large density of states at low energies, so that they are excited even for low temperatures. However, because of the coupling being weak, the dephasing rate remains small, $\sim 2 \times 10^3 \,\mathrm{s}^{-1}$ for $T = 50 \,\mathrm{mK}$ (see Fig. 3). It also decreases rapidly as the temperature is lowered. Another mechanism of dephasing, are slow non-equilibrium drifts in the helium film thickness due to vibrations or acoustic couplings, which change the trap frequency through the dependence on the height, d, of the electron. Fortunately the cavity forms a liquid He channel[21] in which the film height is stabilized by surface tension, rendering it much less susceptible to low frequency excitations.

The electron spin promises much longer coherence times. With no enhancement of the spin-orbit interaction the lifetime is expected to exceed seconds[2]. When the spin is coupled to the motion, it will also inherit the orbital decoherence mechanisms with a matrix element reduced by $\mu_{\rm B}\partial_x B_z a_x/\hbar\omega_x$. These mechanisms can be further diminished by turning off the gradient field or changing the spin-motion detuning, to reduce the coupling. In addition to decoherence felt through the spin-orbit coupling, the electron spin can be dephased by fluctuating magnetic fields. These can arise from Johnson current noise in the leads which would lead to dephasing rates less than $1 s^{-1}$. It is also possible that the spin will be affected by "1/f" flux noise[22], often seen in SQUID experiments. The trap involves no loops or Josephson junctions, so it is difficult to predict to what extent this noise will be present in this geometry, however even a worst case estimate (see suppl. material) still yields a dephasing rate of only $200 \, s^{-1}$.

While electrons on helium have been studied for some time, many fundamental questions remain unanswered. For example, single electron motion and electron spins (either individual electrons or in ensembles) have never been measured, due to a lack of suitable detection technology. The circuit QED approach proposed here, gives a new route to detection and manipulation of these interesting states. Once controlled, the trapped electrons could themselves serve to probe the physics of phonons, ripplons, vortices and other excitations of superfluid helium. It appears that both the motional and spin coherence times can be long, making the architecture described here a promising candidate for quantum information processing and the study of cavity QED.

The authors would like to acknowledge useful discussions with Forrest Bradbury. This work was supported in part by the NSF grants DMR-053377, EMT/QIS 0829854 and CCF-0726490, as well as by Yale University via the Quantum Information and Mesoscopic Physics Fellowship (DIS).

- [1] K. Shirahama, et al., J. Low Temp. Phys. 101, 439 (1995).
- [2] S. A. Lyon, Phys. Rev. A 74, 052338 (2006).
- [3] P. M. Platzman and M. I. Dykman, Science 284, 1967 (1999).
- [4] M. I. Dykman, P. M. Platzman, and P. Seddighrad, Phys. Rev. B 67, 155402 (2003).
- [5] A. Wallraff, et al., Nature **431**, 162 (2004).
- [6] S. Peil and G. Gabrielse, Phys. Rev. Lett. 83, 1287 (1999).
- [7] L. Childress, A. S. Sorensen, and M. D. Lukin, Phys. Rev. A 69, 042302 (2004).
- [8] G. Sabouret, et al., Appl. Phys. Lett. 92, 082104 (2008).
- [9] G. Papageorgiou, et al., Appl. Phys. Lett. 86, 153106 (2005).
- [10] J. R. Petta, et al., Science 309, 2180 (2005).
- [11] F. H. L. Koppens, et al., Nature 442, 766 (2006).
- [12] T. Fujisawa, et al., Science **282**, 932 (1998).
- [13] R. Hanson, et al., Rev. Mod. Phys. 79, 1217 (2007).
- [14] A. C. Johnson, et al., Nature 435, 925 (2005).
- [15] E. Y. Andrei, ed., Two-dimensional electron systems on helium and other cryogenic substrates (Kluwer, Boston, 1997).
- [16] M. I. Dykman and M. A. Krivoglaz, Soviet Physics Reviews (Harwood Academic, New York, 1984), vol. 5, pp. 265– 441.
- [17] A. Blais, et al., Phys. Rev. A 75, 032329 (2007).
- [18] J. M. Martinis, et al., Phys. Rev. B 67, 094510 (2003).
- [19] A. A. Houck, et al., Phys. Rev. Lett. 101, 080502 (2008).
- [20] K. Seeger, *Semiconductor Physics: An Introduction* (Springer-Verlag, Berlin, 2004), 9th ed.
- [21] P. Glasson, et al., Phys. Rev. Lett. 87, 176802 (2001).
- [22] R. H. Koch and et. al., J. Low Temp. Phys. 51, 207 (1983).

Supplementary material for "Circuit Quantum Electrodynamics with Electrons on Helium"

David Schuster,¹ Andreas Fragner,¹ Mark Dykman,² Steve Lyon,³ and Rob Schoelkopf¹

¹Department of Applied Physics and Physics, Yale University

²Department of Physics and Astronomy, Michigan State University

³Department of Electrical Engineering, Princeton University

(Dated: December 14, 2009)

INTRODUCTION

zero pressing field E_{\perp} is

These supplementary materials estimate the rates of relaxation and dephasing of the quantized electron motion in a small electrostatic trap. A variety of decoherence mechanisms are explored including, electric and magnetic noise from the electrodes as well as emission and scattering of ripplons and phonons. We use DPS where we refer to Dykman et al, PRB **67**, 155402 (2003)[4]. The notations below are from this paper. We refer to Eq. (X) in this paper as DPS (X). A discussion of the relaxation and dephasing of the electron spin can be found elsewhere[2].

DEFINITIONS AND USEFUL RELATIONS

In addition to the constants defined in the main text and DPS there are some definitions and relations that will be useful throughout these materials. The motional state of the electron is represented as $|n_x, n_y\rangle$ where $n_{\{x,y\}}$ is the quantum number in the x, y direction. The corresponding transition frequencies are ω_i and the localization lengths are $a_i = (\hbar/m\omega_i)^{1/2}$, with i = x, y. In this supplement the electron is assumed to remain in the ground state of motion normal to the helium surface.

With these notations, we have

$$g_{l}(\mathbf{q}) = \left| \langle 1, 0 | e^{i\mathbf{q} \cdot \mathbf{r}} | 0, 0 \rangle \right|^{2} \\ = \frac{1}{2} (q_{x} a_{x})^{2} e^{-\sum_{j} q_{j}^{2} a_{j}^{2}/2}, \qquad (1)$$

$$g_{ph}(\mathbf{q}) = |\langle 1, 0|e^{i\mathbf{q}\cdot\mathbf{r}}|1, 0\rangle - \langle 0, 0|e^{i\mathbf{q}\cdot\mathbf{r}}|0, 0\rangle|^{2} = \frac{1}{4}(q_{x}a_{x})^{4}e^{-\sum_{j}q_{j}^{2}a_{j}^{2}/2}.$$
 (2)

Respectively,

$$\frac{1}{(2\pi)^2} \int d\mathbf{q} g_l(\mathbf{q}) = \frac{1}{4\pi a_x a_y} \\ \frac{1}{(2\pi)^2} \int d\mathbf{q} g_{ph}(\mathbf{q}) = \frac{3}{8\pi a_x a_y}$$
(3)

The kinetic energy normal to the helium surface for

$$z \langle 1|p_{z}^{2}/2m|1\rangle_{z} = R$$

$$R = \frac{\hbar^{2}}{2mr_{\rm B}^{2}} \approx h \times 158 \,\text{GHz}$$

$$r_{\rm B} = \hbar^{2}/\Lambda m \approx 7.64 \,\text{nm},$$

$$\Lambda = \frac{(\epsilon_{\rm he} - 1)e^{2}}{4(\epsilon_{\rm he} + 1)},$$
(4)

where $|1\rangle_z$ is the ground state wave function of motion normal to the helium surface.

It is also helpful to include several properties of helium. The dielectric constant of helium is $\epsilon_{\rm he} \approx 1.057$. The density of helium is $\rho = 0.145 \,\mathrm{g/cm}^3$, with surface tension $\sigma = .378 \,\mathrm{dyne/cm}$, and a dispersion relation for capillary waves (ripplons) is $\omega_q = (\sigma q^3/\rho)^{1/2}$. For phonons the dispersion relation is $\omega_Q = Q\nu_s$, with $\nu_{\rm s} \approx 2.4 \times 10^4 \,\mathrm{cm/s}$ the speed of sound in superfluid helium.

For obtaining numerical results the following discussion will assume that the electron vibrational frequency is $\omega_x \approx 5 \text{ GHz}$, the zero-point motion of the electron is $a_x \approx 4.8 \text{ nm}$, and $g \approx 25 \text{ MHz}$.

LIFETIME

The general prescription of this section will be to write down Fermi's golden rule with the appropriate matrix element for the specific process. The matrix element will then be evaluated and integrated over the appropriate density of states.

Photon emission

A vibrating electron can emit a photon via electricdipole radiation into the vacuum. If the electron were in vacuum it would radiate at a rate

$$\Gamma_1^{(v)} = \frac{2}{3} \frac{e^2}{\hbar c} \left(\frac{2\pi a_x}{\lambda}\right)^2 \omega_x \tag{5}$$

where $\lambda = 2\pi c/\omega_x$ is the wavelength of the vibrational frequency. If this were the only relaxation process the excited state would last for longer than 100 s.

Of course, the electron is embedded in the electromagnetic environment created by the microwave resonator and bias wiring. For a simple two-level dipole coupled to a single mode cavity with frequency ω_c for nonresonant coupling, $g \ll |\omega_x - \omega_c|$, the spontaneous emission rate is

$$\Gamma_1^{(\mathbf{v})} = \frac{g^2 \kappa}{(\omega_x - \omega_c)^2} \tag{6}$$

where κ is the mode decay rate. In the resonant case and in the bad cavity limit, where the cavity decay is faster than the coupling and the detuning, $\kappa \gg g$, $|\omega_x - \omega_c|$, the decay rate is $\Gamma_v = g^2/\kappa$. In the strong coupling limit, the rate of emission is $\Gamma_1^{(v)} = \kappa/2$ on resonance. It is also possible to model the case of a dipole in multi-mode cavity circuit[19].

In addition to the emission through the cavity, the electron can also decay through the trap bias lead. This decay rate can be found by considering the effect of the Nyquist noise, $S_{V_e}(\omega_x) \approx 2\hbar\omega_x \operatorname{Re}[Z(\omega_x)]$ of the bias electrode on the electron. If there are no other fields, the bias electrode only couples to \hat{x}^2 , and would not cause relaxation. However any displacement Δx from the bias electrode null, due to stray or intential DC fields from other electrodes will add a \hat{x} interaction and will open a channel of relaxation. In this case the coupling to the electrode potential fluctuations δV_e is given by $\hat{h}\delta V_e$, with $\hat{h} = e\hat{x}\partial E_x/\partial V_e$, where E_x is the electrode. The decay rate is then

$$\Gamma_{1}^{(\text{el})} = \frac{1}{\hbar^{2}} \left| \langle 0, 0 | \hat{h} | 1, 0 \rangle \right|^{2} S_{V_{e}}(\omega_{x}).$$
(7)

For small Δx compared to the inter-electrode distance, we have $eE_x = m_e \omega_x^2 \Delta x = \hbar \omega_x \Delta x / a_x^2$. Substituting these results into Eq. 7 and allowing for $\partial E_x / \partial V_e = E_x / V_e$, one obtains

$$\Gamma_1^{(\text{el})} = \frac{\text{Re}[Z(\omega_x)]}{\hbar/e^2} \left(\frac{\hbar\omega_x}{eV_e}\right)^2 \omega_x \tag{8}$$

Even assuming that the electron is displaced significantly, $\Delta x \approx a_x$ and $\operatorname{Re}[Z(\omega_x)] \approx 50 \,\Omega$, this relaxation is quite small $\Gamma_1^{(v)} \approx 1.6 \times 10^3 s^{-1}$ and should not be a limiting factor. If this becomes a hindrance in the future it can be reduced by several orders of magnitude by changing $\operatorname{Re}[Z(\omega_x)]$ using a resonant structure.

Two-ripplon scattering

Single ripplon scattering is exponentially suppressed by the mismatch of the size of the electron wave function to the ripplon wavelength at the same energy. The dominant decay process is one in which two ripplons are emitted in nearly opposite directions, each with approximately half of the electron energy $\hbar\omega_x$. The decay rate due to such a process can be estimated by applying Fermi's Golden rule to DPS(11)

$$\Gamma_{1}^{(2r)} = \frac{2\pi}{\hbar} \sum_{\mathbf{q}_{1},\mathbf{q}_{2}} \left| \langle 0, 0 | \xi_{\mathbf{q}_{1}} \xi_{\mathbf{q}_{2}} e^{i(\mathbf{q}_{1}+\mathbf{q}_{2}) \cdot \mathbf{r}} V_{\mathbf{q}_{1},\mathbf{q}_{2}} | 1, 0 \rangle \right|^{2} \\ \times \delta(\hbar\omega - \hbar\omega_{q_{1}} - \hbar\omega_{q_{1}}) (\bar{n}_{q_{1}} + \bar{n}_{q_{2}} + 1), \qquad (9)$$

where $\xi_{\mathbf{q}}$ is the helium surface displacement due to a ripplon with wave vector \mathbf{q} and $\bar{n}_q \equiv \bar{n}(\omega_q)$, with $\bar{n}(\omega) = [\exp(\hbar\omega/k_{\rm B}T) - 1]^{-1}$. This calculation can be simplified significantly by noticing that, because of the Gaussian form of the matrix element Eq. (1), $|\mathbf{q}_1 + \mathbf{q}_2| \leq 1/a_x$. Since $q_{\rm res}$ found from condition $2\omega_{q_{\rm res}} = \omega_x$ is $\approx 4.6 \times 10^6$ cm and $q_{\rm res}a_x \approx 30$, we approximate $|\mathbf{q}_1| \approx |\mathbf{q}_2| = q_{\rm res}$.

The strength of the direct two-rippion coupling $V_{\mathbf{q}_1\mathbf{q}_2}$ is a sum of contributions from the kinetic, or inertial term (from electron accommodating to the curvature of the barrier on the helium surface), and a polarization term, which comes from the change of the image potential due to the curvature of the surface. In Eq. 9 and below it should be assumed unless otherwise stated that $V_{\mathbf{q}_1\mathbf{q}_2}$ is the matrix element of the interaction with rippions or phonons on out-of plane wave functions $|1\rangle_z$. A simple calculation shows that the main contribution to scattering comes from the kinetic term, see DPS (11)-(13),

$$V_{\mathbf{q}_1\mathbf{q}_2} \approx -R\mathbf{q}_1\mathbf{q}_2. \tag{10}$$

A correction from the polarization term, DPS (13), is comparatively small. The corresponding matrix element of the interaction is

$$\Lambda z^{-3}[2 - x^2 K_2(x)] \approx 4.6 R/r_B^2 \tag{11}$$

with $x = q_{\rm res} z$. The ratio of this term to the kineticenergy term is 40%. The remaining term in the polarization coupling, DPS (13), is even smaller and partly compensates the above term. The contribution of the polarization coupling decreases, relatively, when we apply a pressing field.

Using this approximation to evaluate the matrix element and converting the sum to an integral yields

$$\Gamma_1^{(2r)} = \frac{\hbar}{16\pi^2 \rho^2} \left(\int d\mathbf{q} g_l(\mathbf{q}) \right)$$
$$\times \int dq \frac{q^3}{\omega_q^2} \left(q^2 R \right)^2 \delta(\hbar\omega - 2\hbar\omega_q) (2\bar{n}_q + 1)$$
$$\approx \frac{R^2}{192\pi a_x a_y} \frac{\rho^{2/3} \omega_x^{7/3}}{2^{1/3} \sigma^{8/3}} \tag{12}$$

This rate is small, $\sim 450 \text{ s}^{-1}$.

Renormalization due to single-ripplon coupling

The single-ripplon coupling leads to renormalization of the two-ripplon coupling. The renormalization leads to the replacement of the matrix element of two-ripplon coupling

$$\langle \mu | e^{i(\mathbf{q}_1 + \mathbf{q}_2)\mathbf{r}} \hat{V}_{\mathbf{q}_1 \mathbf{q}_2} | \nu \rangle \rightarrow \langle \mu | e^{i(\mathbf{q}_1 + \mathbf{q}_2)\mathbf{r}} \hat{V}_{\mathbf{q}_1 \mathbf{q}_2} | \nu \rangle$$

$$- \frac{1}{2} \sum_{\kappa} V_{\mu\kappa}(\mathbf{q}_1) V_{\kappa\nu}(\mathbf{q}_2) \left[(\varepsilon_{\kappa} - \varepsilon_{\nu})^{-1} + (\varepsilon_{\kappa} - \varepsilon_{\mu})^{-1} \right],$$

$$V_{\mu\nu}(\mathbf{q}) = \langle \mu | e^{i\mathbf{q}\mathbf{r}} \hat{V}_{\mathbf{q}} | \nu \rangle.$$

$$(13)$$

Here, $|\mu\rangle$ are electron states (μ enumerates both in-plane and out-of-plane states), ε_{μ} are the state energies. We have disregarded the dynamics of ripplons, i.e., we assume that the change of the electron energy in a virtual transition is much larger than the ripplon energy change. The explicit form of the coupling matrix element (an operator with respect to motion normal to the surface) $V_{\mathbf{q}}$ is given by DPS (10). We need virtual transitions into such states μ that the matrix elements $\langle \mu_{\parallel} | \exp(i\mathbf{qr}) | 0, 0 \rangle$ is of order 1 for $q \sim q_{\rm res}$, where $|\mu_{\parallel}\rangle$ is the in-plane component of the wave function $|\mu\rangle$. This condition leads to typical $\varepsilon_{\mu} \approx \hbar^2 q_{\rm res}^2 / 2m$. Such energy is very large, ~ 12R. The terms in $\hat{V}_{\mathbf{q}}$ that are $\propto q^2$ are also large for such q. They lead to renormalization [?] of the matrix elements of direct two-ripplon coupling, reducing them by a factor $\propto (qr_B)^{-1}$ which is ~ 0.3 for $q = q_{\rm res}$. The polarization coupling is also reduced. Therefore, the rate of two-ripplon decay is reduced down to $< 10^3 \text{ s}^{-1}$.

Phonon scattering

Another way that the electron motion can relax is through phonon emission. The electron can launch a phonon by two mechanisms. In the first the coupling is mediated by modulation of the dielectric constant along with the density wave. In the second, the electron can couple to the surface displacement in much the same way as in the ripplon case but now launching most of the energy normal to the surface.

Phonon scattering: dielectric constant modulation

For frequency $\omega_x = 5$ GHz and phonon sound velocity $\nu_s = 2.4 \times 10^4$ cm/s, we have the normal to the surface component of the wave vector of the resonant phonon $(Q_z)_r = \omega_x/\nu_s \approx 1.3 \times 10^6$ cm⁻¹, whereas the typical inplane wave number $q_x = (m\omega_x/\hbar)^{1/2} \approx 1.6 \times 10^5$ cm⁻¹. This shows that the phonons involved in inelastic scattering propagate almost normal to the surface. We will modify DPS (25) - (27) to write the interaction in terms of the velocity potential

$$\phi(\mathbf{r}, z) = \sum_{\mathbf{Q}} \phi_{\mathbf{Q}} \left(\hat{c}_{\mathbf{q} Q_z} + \hat{c}_{-\mathbf{q} Q_z}^{\dagger} \right) e^{i\mathbf{q}\mathbf{r}} \sin(Q_z z),$$

$$\phi_{\mathbf{Q}} = (\hbar\nu_s/\rho V Q)^{1/2}, \qquad \mathbf{Q} = (\mathbf{q}, Q_z), \tag{14}$$

where $\hat{c}_{\mathbf{q}Q_z}$ is the annihilation operator of a phonon with the wave number (\mathbf{q}, Q_z) ; \mathbf{r}, \mathbf{q} are two-dimensional vectors and $Q_z > 0$. Using the Fermi golden rule, for $\bar{n}(\omega_x) \ll 1$ the decay rate can be written as

$$\Gamma_{1}^{(d)} = \frac{2\pi}{\hbar} \sum_{\mathbf{Q}} \left| \langle 0, 0 | \phi_{\mathbf{Q}} e^{i\mathbf{q}\cdot\mathbf{r}} V_{\mathbf{Q}}^{(d)} | 1, 0 \rangle \right|^{2} \\ \times \delta(\hbar\omega_{x} - \hbar\omega_{Q}^{(\mathrm{ph})}), \qquad (15)$$

$$V_{\mathbf{Q}}^{(d)} = \frac{i\Lambda qQ}{\nu_{s}} {}_{z} \langle 1 | v^{(d)} | 1 \rangle_{z}, \\ v^{(d)} = \int_{0}^{\infty} dz' (z+z')^{-1} \sin(Q_{z}z') K_{1}[q(z+z')].$$

Here, $\omega_Q^{(\text{ph})}$ is the phonon frequency.

Using the explicit form of the ground-state wave function and taking into consideration that the typical inplane wave numbers are small, $q \ll 1/r_B$, so that in Eq. (15) $K_1[q(z + z')] \approx 1/q(z + z')$ (this is an overestimate), one can write the expression for the decay rate due to modulation of the dielectric constant ε as

$$\Gamma_{1}^{(d)} = 32R^{2}\omega_{x} / \left(\pi\rho\nu_{s}^{3}\hbar a_{x}a_{y}\right) \\ \times \left|\int_{0}^{\infty} dz_{1} dz_{2} \left(\frac{z_{1}}{z_{1}+z_{2}}\right)^{2} e^{-2z_{1}} \sin(Q_{z}r_{B}z_{2})\right|^{2} (16)$$

The dimensional factor in front of the integral in Eq. (16) is $4.3 \times 10^6 \text{ s}^{-1}$. With $(Q_z)_r r_B^{(0)} = 1.01$ this gives the overall rate of $\sim 2.7 \times 10^4 \text{ s}^{-1}$.

Phonon scattering: surface displacement

The contribution to the decay rate comes also from the displacement of the helium surface, which can be considered a free surface for high-energy phonons propagating almost normal to it. This is much like the ripplon case, but here a single-phonon decay is allowed because the 2D momentum is conserved while the excess energy is dumped into the normal component. The decay rate can be expressed as

$$\Gamma_{1}^{(s)} = -\frac{2\pi}{\hbar\nu_{s}^{2}} \sum_{\mathbf{Q}} \left| \langle 0, 0 | \phi_{\mathbf{Q}} e^{i\mathbf{q}\cdot\mathbf{r}} \overline{V_{\mathbf{q}}} | 1, 0 \rangle \right|^{2} \\ \times \delta(\hbar\omega - \hbar\omega_{Q}^{(\text{ph})}).$$
(17)

Here, $\overline{V_{\mathbf{q}}}$ is the diagonal matrix element of the coupling operator $\hat{V}_{\mathbf{q}}$, which is detailed in DPS (9) - (10), calculated on the wave functions of the ground state of motion normal to the helium surface,

$$\overline{V_{\mathbf{q}}} = {}_{z} \langle 1 | \hat{V}_{\mathbf{q}} | 1 \rangle_{z} = e E_{\perp} + \Lambda q^{2} \langle v_{\text{pol}} \rangle, \qquad (18)$$

where E_{\perp} is the electric field that presses the electron against the surface and $\langle v_{\rm pol} \rangle = {}_{z} \langle 1 | (qz)^{-2} [1 -$

 $qzK_1(qz)|1\rangle_z$. Then

$$\Gamma_1^{(s)} = -\frac{2}{\hbar\rho\nu_s\omega_x}\frac{1}{(2\pi)^2}\int d\mathbf{q}g_l(\mathbf{q})\left|\overline{V_{\mathbf{q}}}\right|^2$$
(19)

The contribution from the pressing field is

$$\Gamma_1^{(E_\perp)} = \frac{e^2 E_\perp^2}{2\pi\hbar\rho\nu_s\omega_x a_x a_y} \tag{20}$$

For a comparatively strong field $E_{\perp} = 300$ V/cm this rate is 8.6×10^3 s⁻¹.

We now consider the contribution to $\Gamma_1^{(s)}$ of the term $\langle v_{\text{pol}} \rangle$. For typical $q \leq 1/a_x$ we have $\langle v_{\text{pol}} \rangle \sim -\ln(qr_B)/2$. Using this approximation, we obtain for the corresponding contribution

$$\Gamma_{1}^{(\text{pol})} = \frac{\Lambda^{2}}{2\pi^{2}\hbar\rho\nu_{s}\omega_{x}}\int d\mathbf{q} \,q^{4}g_{l}(\mathbf{q})|\langle\nu_{\text{pol}}\rangle|^{2}$$
$$\sim \frac{48R^{2}r_{B}^{2}}{\pi\hbar\rho\nu_{s}\omega_{x}a_{x}^{6}}\left[\ln(r_{B}/a_{x})/2\right]^{2}. \tag{21}$$

Here, we assumed that $a_x \sim a_y$. The last factor is somewhat smaller than the numerical result for actual r_B/a_x . For a numerical estimate we set it equal to one. This gives $1.8 \times 10^3 \text{ s}^{-1}$. There is an interference term of the two last expressions, but it is smaller than their sum.

Therefore, polarization phonon scattering is the dominating mechanism of inelastic scattering due to excitations in liquid helium.

Lifetime summary

There are several contributions to the lifetime of the excited vibrational state of the electron. There are effects which could modify these results (though the estimates here are conservative), but in the current analysis the dominant mechanism appears to be phonon emission, coupled mostly via modulation of the dielectric constant. It gives the lifetime of the vibrational state $T_1 \approx 35\mu$ s.

DEPHASING

In addition to loss of coherence of the electron due to decay processes, excitations in the environment at low frequencies can cause variations in the transition frequency, leading to dephasing of superposition states. In this section we treat dephasing from voltage noise, variations in helium level, and state dependent quasi-elastic scattering of ripplons off the electron.

Voltage noise

The depth of the potential and thus the electron transition frequency depends on the trap bias voltage. Any low frequency noise on the bias electrode will result in electron phase noise. Noise on the bias lead can arise from slow drift of the voltage source, thermal fluctuations (Johnson noise), or anomalous local sources (1/f noise). For typical electrode geometries the transition frequency scales like $\omega_x \propto V_e^{1/2}$. Small changes in V_e cause a frequency shift $\delta \omega = -\omega_x \delta V_e/2V_e$. Typical long term drifts for precision voltage sources are $\delta V_e/V_e \approx 10^{-6}$, or a drift of about $\delta \omega_x \approx 8 \times 10^3 s^{-1}$. Because this drift is typically on hour timescales it should be easily compensated by measuring the transition frequency and readjusting the voltage. For thermal noise [18]

$$\Gamma_{\phi}^{(v)} = \left(\frac{\partial \omega_x}{\partial V_e}\right)^2 S_{V_e}/2$$
$$= \frac{\omega^2 k_{\rm B} T Re \left[Z(\omega)\right]}{4V_e^2} \tag{22}$$

If superconducting leads are used then there is no local Johnson noise but noise can still be coupled in from dissipative sources off chip. For the simulated bias voltage $V_e \approx 10 \text{ mV}$ and conservatively assuming an environmental impedance of $Z = 50 \Omega$, Eq. 22 gives $\Gamma_{\phi}^{(v)} \approx 90s^{-1}$.

Usually the dominant source of electrical dephasing is 1/f noise which is thought to arise from mobile charges in the substrate. This type of noise spectrum does not lead to a simple dephasing rate. The diffusion of phase can be estimated as [18]

$$\langle [\phi(t) - \phi(0)]^2 \rangle \sim \left(\frac{\partial \omega_x}{\partial V_e} \right)^2 S_{V_e}(1 \,\mathrm{Hz}) \ln(0.4/\mathrm{f_mt}) \mathrm{t}^2$$
$$= \frac{(\omega_x t)^2}{4V_e^2} S_{V_e}(1 \,\mathrm{Hz}) \ln(0.4/\mathrm{f_mt}) \quad (23)$$

where f_m^{-1} is the total averaging time, and t is the precession time of single measurement. The dephasing time for uncompensated 1/f noise can be estimated as the time for $\langle [\phi(t_{\pi}) - \phi(0)]^2 \rangle = \pi$. Local charges should be screened by the bias electrode. To get an estimate of their effect we assume that $S_{V_e} = S_q/C_{\text{eff}}$ and that the effective capacitance is only $C_{\text{eff}} \approx 1 \,\text{fF}$ (though it should be much more than that) and the "typical" charge noise of $S_q(1\,\text{Hz}) \approx 10^{-4}\,\text{e/Hz}^{1/2}$. With these assumptions $t_{\pi}^{-1} = 8 \times 10^3 \,\text{s}^{-1}$. Even these conservative assumptions lead to rates smaller than the relaxation rates, which can be seen as a result of the electron being physically separated from the electrodes where the charges may fluctuate.

Fluctuations in helium level

The potential energy landscape is created by electrostatic gates beneath the helium surface. Any fluctuations in the thickness of the helium above the electrodes will change the effective voltage seen by the electron resulting in changes to the transition frequency. While quantized excitations in the helium level will be treated in the next section, here we explore the effect and susceptibility to slow changes in the level of liquid helium in the reservoir due to fluctuations in temperature, or external vibrations. This type of fluctuation is unlikely to cause dephasing during the lifetime of the qubit and should be susceptible to spin-echo techniques, but if unchecked can lead to slow drifts in the frequency, making it difficult to bias the electron reliably.

For the geometry simulated in Fig. 2 the transition frequency has a sensitivity to small fluctuations in the mean helium film thickness of $\partial \omega_x / \partial d \approx 10 \,\mathrm{MHz/nm}$. Fortunately superfluid has two properties, the formation of a Van der Waals film, and ideal capillary action that help stabilize the film thickness. Exploiting these properties, the electron can be trapped above a channel? in which the thickness is determined by the geometry and surface tension. The trap is supplied by the Van der Waals creep film from a reservoir located well below the trap?], significantly reducing its sensitivity to fluctuations in the reservoir height. To accomplish this we design the guard ring of the trap to be much thicker than the bias electrode, forming a channel of the desired height. The superfluid obeys Jurin's law, $R_{\rm c} = 2\sigma/\rho g H$ causing it to fill the trap if it is smaller than $R_{\rm c}$, the capillary radius of curvature [?]. For $H = 5 \,\mathrm{mm}$, the capillary length is $R_{\rm c} \approx 53 \,\mu{\rm m}$ and the trap is well filled, with sensitivity reduced by $\partial_H R_c \partial_{R_c} d = w/H \approx 10^{-4}$.

Direct two-ripplon coupling

An important contribution to dephasing is due to thermally excited ripplons. For T= 100 mK the typical wave number of a thermal ripplon ($\hbar\omega_{q_T} = k_{\rm B}T$) is $q_T \approx 4.1 \times 10^6$ cm⁻¹. Therefore $q_T r_B \approx 3.1$. For T=50 mK we have $q_T \approx 2.5 \times 10^8$ cm⁻¹ and $q_T r_B \approx 1.96$). The dephasing rate is given by the difference of the diagonal interaction matrix elements on the wave functions of the excited and ground vibrational states. The overall interaction matrix elements need to be projected on the ground state of out-of-plane motion, that is the relevant interaction can be written as [cf. DPS (32)]

$$H_{i}^{\phi} = \sum_{j=1,2} \sum_{\mathbf{q}_{1},\mathbf{q}_{2}} v_{j}(\mathbf{q}_{1},\mathbf{q}_{2}) b_{\mathbf{q}_{1}}^{\dagger} b_{\mathbf{q}_{2}} |j,0\rangle\langle j,0| \qquad (24)$$

with

$$v_j(\mathbf{q}_1, \mathbf{q}_2) = (\hbar/\rho)(q_1q_2/\omega_{q_1}\omega_{q_2})^{1/2}V_{\mathbf{q}_1-\mathbf{q}_2}$$
$$\times \langle j, 0| \exp[i(\mathbf{q}_1-\mathbf{q}_2)\mathbf{r}]|j, 0\rangle.$$

A useful relation for the following calculation is Eq. (2). For $q_T r_B \gg 1$ the major direct two-ripplon coupling is the kinematic coupling, with the projection given by Eq. (10). With account taken of DPS (32)-(33), the dephasing rate given by this interaction has the form

$$\Gamma_{\phi}^{(2\mathbf{r})} = \frac{\pi R^2}{S^2} \sum_{\mathbf{q}_1, \mathbf{q}_2} \left(\frac{q_1}{\rho \omega(q_1)} \right)^2 (\mathbf{q}_1 \mathbf{q}_2)^2 g_{ph}(\mathbf{q}_1 + \mathbf{q}_2) \\
\times \bar{n}_{q_1} \left(\bar{n}_{q_2} + 1 \right) \delta \left(\omega_{q_1} - \omega_{q_2} \right)$$
(25)

(S is the area). For $q_T \gg 1/a_{x,y}$, we can calculate this expression using that $|\mathbf{q}_1 - \mathbf{q}_2| \ll q_{1,2} \sim q_T$. The calculation is further simplified if we set $a_x = a_y$, in which case we can average over the directions of $\mathbf{q}_{1,2}$, which leads to the replacement $g_{ph}(\mathbf{q}) \to (3/32)(qa_x)^4 \exp(-q^2a_x^2/2)$. We can then integrate first over \mathbf{q}_2 for given \mathbf{q}_1 by writing $\mathbf{q}_2 = q'\hat{\mathbf{q}}_1 + q''(\hat{\mathbf{q}}_1 \times \hat{\mathbf{z}})$ (hat indicates a unit vector). The inequality $|\mathbf{q}_1 - \mathbf{q}_2| \ll q_{1,2}$ shows that $|q'| \gg |q''|$. To leading order in $(a_xq_T)^{-1}$ we have $\omega_{q_2} \approx \omega_{q'}$ and $\mathbf{q}_1 - \mathbf{q}_2 \approx q''(\hat{\mathbf{q}}_1 \times \hat{\mathbf{z}})$. Integration over q', q'' then becomes simple, and the remaining integration over \mathbf{q}_1 is then reduced to integration of the weighted temperaturedependent factor $\bar{n}_{q_1}(\bar{n}_{q_1} + 1)$. The overall result is

$$\Gamma_{\phi}^{(2\mathrm{r})} \approx \frac{(2\pi)^{1/2}}{192} \frac{\rho R^2}{\sigma^3 a_x} (k_{\mathrm{B}} T/\hbar)^3.$$
 (26)

For 100 mK this gives $\sim 1.4 \times 10^4 \text{ s}^{-1}$.

For T~ 100 mK the polarization part of the direct two-ripplon coupling is small compared to the kinematic part. However, its role increases with decreasing temperature, since the characteristic ripplon wave number q_T decreases. For $\mathbf{q}_1 \approx \mathbf{q}_2 = \mathbf{q}$, the matrix element of the polarization coupling $-_z \langle 1 | \Lambda z^{-3} [2 - (qz)^2 K_2(qz)] | 1 \rangle_z$ changes from $\approx -0.9 Rq^2$ to $\approx -0.6 Rq^2$ for q increasing from $0.3/r_B$ to $1.2/r_B$. It is thus comparable with the kinematic coupling Rq^2 and has opposite sign. Therefore the overall contribution to the dephasing rate from direct two-ripplon coupling is significantly less than from the kinematic coupling taken alone, which from Eq. (26) is $\sim 1.7 \times 10^{-3} \text{ s}^{-1}$ for T=50 mK.

Renormalization due to single-ripplon coupling

The kinematic and polarization single-ripplon coupling taken to the second order of the perturbation theory renormalizes the matrix elements of the direct tworipplon coupling. For $q_{1,2}r_B \gg 1$ it reduces these matrix elements by a factor $\sim 1/q_{1,2}r_B$ [?]. This leads to a significant reduction of the dephasing rate for T=100 mK, since $q_T r_B \approx 3$ for such temperature. On the other hand, for lower temperatures down to T=50 mK, where $q_T r_B \approx 1.96$, the compensation is not strong, but the dephasing rate is already small here. The effect of the pressing field E_{\perp} remains smaller than from the polarization single-ripplon coupling for $E_{\perp} \ll 10^3$ V/cm.

Dephasing summary

Ideally pure dephasing would be limited by the interaction of the electron motion with thermal ripplons. This would set a dephasing time of $T_{\phi} \approx 0.5$ ms even for T=100 mK. This value would be very sensitive to temperature and could be reduced significantly at temperatures lower than 50 mK, giving it a distinctive signature. It is possible, perhaps likely, that initial experiments will be dominated by anomalously high contributions from outside sources such as helium level fluctuations due to vibrations or spurious noise on the bias line, but given the analysis presented here it appears that it will be possible to eventually reduce these to acceptable levels.

SPIN DECOHERENCE

In the absence of the enhanced spin-orbit interaction the lifetime of electron spin states is expected to exceed seconds [2]. When the spin is coupled to the motion, it will also inherit the orbital decoherence mechanisms studied above with a matrix element reduced by $\propto \mu_{\rm B} \partial_x B_z a_x / \hbar \omega_x$. These mechanisms can be reduced by turning off the gradient field or changing the spinmotion detuning, to reduce the coupling. In addition to decoherence felt through the spin-orbit coupling, the electron spin can be dephased by fluctuating magnetic fields. One source of magnetic field noise is Johnson (current) noise in the trap electrodes, a white noise given by $S_{\rm I} = 4kT\Delta\omega/{\rm Re}$ Z, where $\Delta\omega$ is the bandwidth of interest, and the real part of the impedance is typically Re Z $\sim 50 \Omega$. The field created at the electron by a current in the wire is $B = 4 \times 10^3 \,\mathrm{mG/mA}$, corresponding to a frequency shift of $\delta \omega_{\rm L} = 3.50 \times 10^7 {\rm s}^{-1}/{\rm mA}$. The Johnson noise is extremely small $100 \,\mathrm{pA/Hz^{1/2}}$, giving a coherence time $T_{\phi,I} \sim 20 \,\mathrm{s.}$ Another possible source of magnetic field noise is 1/f flux noise[22]. often seen in SQUID experiments with magnitudes of order $S_{\phi,\Phi} = 10^{-6} \Phi_0 / \text{Hz}^{1/2}$. The trap geometry contains no superconducting loops or Josephson junctions so this mechanism may not cause decoherence for an electron on helium. If present it is reasonable to assume the flux would be distributed evenly over the trap area $(\sim 500 \times 500 \,\mathrm{nm^2})$. Even in this conservative scenario the dephasing rate would be $\Gamma_{\phi,\Phi} \sim 200 \,\mathrm{s}^{-1}$, allowing many coherent operations.

- [2] S. A. Lyon, Phys. Rev. A **74**, 052338 (2006).
- [3] P. M. Platzman and M. I. Dykman, Science 284, 1967 (1999).
- [4] M. I. Dykman, P. M. Platzman, and P. Seddighrad, Phys. Rev. B 67, 155402 (2003).
- [5] A. Wallraff, D. I. Schuster, A. Blais, L. Frunzio, R.-S. Huang, J. Majer, S. Kumar, S. M. Girvin, and R. J. Schoelkopf, Nature **431**, 162 (2004).
- [6] S. Peil and G. Gabrielse, Phys. Rev. Lett. 83, 1287 (1999).
- [7] L. Childress, A. S. Sorensen, and M. D. Lukin, Phys. Rev. A 69, 042302 (2004).
- [8] G. Sabouret, F. R. Bradbury, S. Shankar, J. A. Bert, and S. A. Lyon, Appl. Phys. Lett. 92, 082104 (2008).
- [9] G. Papageorgiou, P. Glasson, K. Harrabi, V. Antonov, E. Collin, P. Fozooni, P. G. Frayne, M. J. Lea, D. G. Rees, and Y. Mukharsky, Appl. Phys. Lett. 86, 153106 (2005).
- [10] J. R. Petta, A. C. Johnson, J. M. Taylor, E. A. Laird, A. Yacoby, M. D. Lukin, C. M. Marcus, M. P. Hanson, and A. C. Gossard, Science **309**, 2180 (2005).
- [11] F. H. L. Koppens, C. Buizert, K. J. Tielrooij, I. T. Vink, K. C. Nowack, T. Meunier, L. P. Kouwenhoven, and L. M. K. Vandersypen, Nature 442, 766 (2006).
- [12] T. Fujisawa, T. H. Oosterkamp, W. G. van der Wiel, B. W. Broer, R. Aguado, S. Tarucha, and L. P. Kouwenhoven, Science **282**, 932 (1998).
- [13] R. Hanson, L. P. Kouwenhoven, J. R. Petta, S. Tarucha, and L. M. K. Vandersypen, Rev. Mod. Phys. 79, 1217 (2007).
- [14] A. C. Johnson, J. R. Petta, J. M. Taylor, A. Yacoby, M. D. Lukin, C. M. Marcus, M. P. Hanson, and A. C. Gossard, Nature 435, 925 (2005).
- [15] E. Y. Andrei, ed., Two-dimensional electron systems on helium and other cryogenic substrates (Kluwer, Boston, 1997).
- [16] M. I. Dykman and M. A. Krivoglaz, Soviet Physics Reviews (Harwood Academic, New York, 1984), vol. 5, pp. 265–441.
- [17] A. Blais, J. Gambetta, A. Wallraff, D. I. Schuster, S. M. Girvin, M. H. Devoret, and R. J. Schoelkopf, Phys. Rev. A 75, 032329 (2007).
- [18] J. M. Martinis, S. Nam, J. Aumentado, K. M. Lang, and C. Urbina, Phys. Rev. B 67, 094510 (2003).
- [19] A. A. Houck, J. A. Schreier, B. R. Johnson, J. M. Chow, J. Koch, J. M. Gambetta, D. I. Schuster, L. Frunzio, M. H. Devoret, S. M. Girvin, et al., Phys. Rev. Lett. 101, 080502 (2008).
- [20] K. Seeger, Semiconductor Physics: An Introduction (Springer-Verlag, Berlin, 2004), 9th ed.
- [21] P. Glasson, V. Dotsenko, P. Fozooni, M. J. Lea, W. Bailey, G. Papageorgiou, S. E. Andresen, and A. Kristensen, Phys. Rev. Lett. 87, 176802 (2001).
- [22] R. H. Koch, et. al., J. Low Temp. Phys. 51, 207 (1983).

 K. Shirahama, S. Ito, H. Suto, and K. Kono, J. Low Temp. Phys. **101**, 439 (1995).